

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/733,295	OHNISHI, SHINJI	
		Examiner	Art Unit	Page 1 of 1
		LIN LIU	2145	

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0078161	06-2002	Cheng, Doreen Yining	709/208
*	B	US-2001/0033554	10-2001	Ayyagari et al.	370/328
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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#### FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

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